

Search Notes

Application/Control No.

10/665,469

Examiner

Phillip Nguyen

Applicant(s)/Patent under
Reexamination

ONISHI, TOSHIKAZU

Art Unit

2828

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST text search (see the printout) | 1/6/2006 | PN |
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